

Notice of References Cited	Application/Control No. 10/073,571	Applicant(s)/Patent Under Reexamination DAHNEKE ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0174206 A1	11-2002	Moyer et al.	709/221
	B	US-2003/0033452 A1	02-2003	Himmel et al.	710/9
	C	US-2002/0065950 A1	05-2002	Katz et al.	709/318
	D	US-2002/0062287 A1	05-2002	Katz et al.	705/51
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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